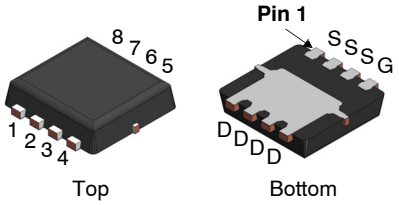
MOSFET – N-Channel, POWERTRENCH®

30 V, 16 A, 14.3 mohm

FDMC8882



WDFN8 3.3x3.3, 0.65P
CASE 511DR

Description

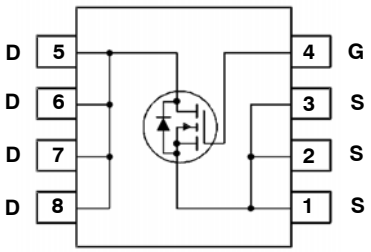
This N−Channel MOSFET is produced using **onsemi**'s advanced POWETRENCH process that has been especially tailored to minimize the on−state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Features

- Max $R_{DS(on)}$ = 14.3 mΩ at V_{GS} = 10 V, I_D = 10.5 A
- Max $R_{DS(on)}$ = 22.5 mΩ at V_{GS} = 4.5 V, I_D = 8.3 A
- High Performance Technology for Extremely Low $R_{DS(on)}$
- Termination is Lead−Free
- RoHS Compliant

Applications

- High Side in DC−DC Buck Converters
- Notebook Battery Power Management
- Load Switch in Notebook



MARKING DIAGRAM

Z	=	Assembly Plant Code
XY	=	Date Code (Year &Week)
KK	=	Lot Traceability Code
FDMC8882	=	Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping†
FDMC8882	WDFN8 (Pb−Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter			Ratings	Unit
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage			±20	V
I_D	Drain Current	Continuous (Package Limited)	T_C = 25°C	16	A
		Continuous (Silicon Limited)	T_C = 25°C	34	
		Continuous	T_A = 25°C (Note 1a)	10.5	A
		Pulsed	–	40	
P_D	Power Dissipation		T_C = 25°C	18	W
	Power Dissipation		T_A = 25°C (Note 1a)	2.3	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction–to–Case	6.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction–to–Ambient (Note 1a)	53	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
BV_{DSS}	Drain–to–Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V	30	–	–	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	–	25	–	mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 24 V, V_{GS} = 0 V	–	–	1	μA
		V_{DS} = 24 V, V_{GS} = 0 V, T_J = 125 °C	–	–	250	
I_{GSS}	Gate–to–Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V	–	–	±100	nA
ON CHARACTERISTICS						
$V_{GS(th)}$	Gate–to–Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250 μA	1.2	1.9	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate–to–Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	–	–5	–	mV/°C
$R_{DS(on)}$	Static Drain–to–Source On Resistance	V_{GS} = 10 V, I_D = 10.5 A	–	12.4	14.3	mΩ
		V_{GS} = 4.5 V, I_D = 8.3 A	–	16.0	22.5	
		V_{GS} = 10 V, I_D = 10.5 A, T_J = 125°C	–	17.4	–	
g_{FS}	Forward Transconductance	V_{DS} = 5 V, I_D = 10.5 A	–	33	–	S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz	–	710	945	pF
C_{oss}	Output Capacitance		–	140	185	pF
C_{rss}	Reverse Transfer Capacitance		–	90	135	pF
R_g	Gate Resistance		–	1.0	–	Ω

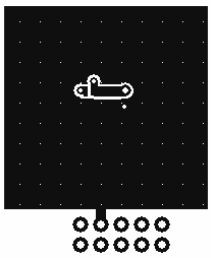
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
SWITCHING CHARACTERISTICS						
$t_{d(on)}$	Turn−On Delay Time	V_{DD} = 15 V, I_D = 10.5 A, V_{GS} = 10 V, R_{GEN} = 6 Ω	–	7	14	ns
t_r	Rise Time		–	3	10	
$t_{d(off)}$	Turn−Off Delay Time		–	17	30	
t_f	Fall Time		–	2	10	
$Q_{g(tot)}$	Total Gate Charge	V_{GS} = 0 V to 10 V, V_{DD} = 15 V, I_D = 10.5 A	–	14	20	nC
	Total Gate Charge	V_{GS} = 0 V to 4.5 V, V_{DD} = 15 V, I_D = 10.5 A	–	7	10	
Q_{gs}	Gate−to−Source Charge	V_{DD} = 15 V, I_D = 10.5 A	–	2.3	–	
Q_{gd}	Gate−to−Drain “Miller” Charge	V_{DD} = 15 V, I_D = 10.5 A	–	2.8	–	
DRAIN−SOURCE DIODE CHARACTERISTICS						
V_{SD}	Source−to−Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 10.5 A (Note 2)	–	0.88	1.2	V
		V_{GS} = 0 V, I_S = 1.9 A (Note 2)	–	0.76	1.2	
t_{rr}	Reverse Recovery Time	I_F = 10.5 A, di/dt = 100 A/μs	–	16	28	ns
Q_{rr}	Reverse Recovery Charge		–	4.4	10	nC

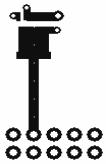
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR−4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user’s board design.



a) 53°C/W when mounted on a 1 in^2 pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

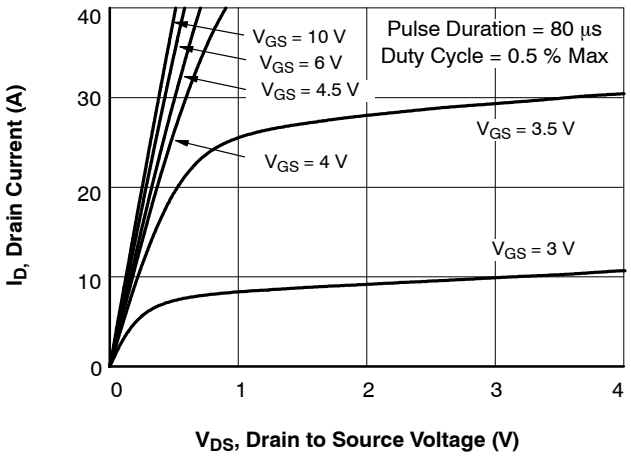


Figure 1. On−Region Characteristics

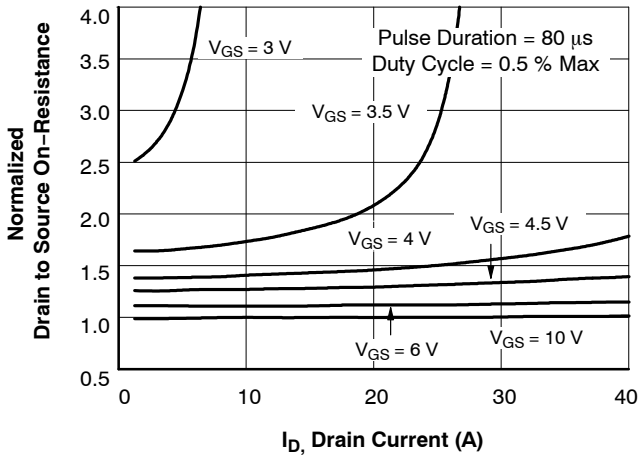


Figure 2. Normalized On−Resistance vs. Drain Current and Gate Voltage

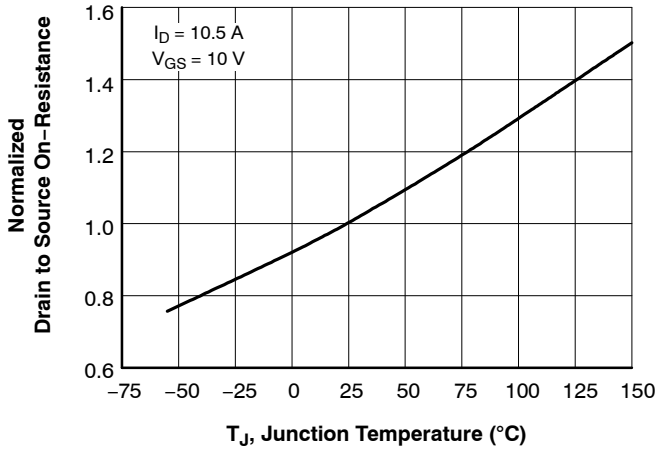


Figure 3. Normalized On−Resistance vs. Junction Temperature

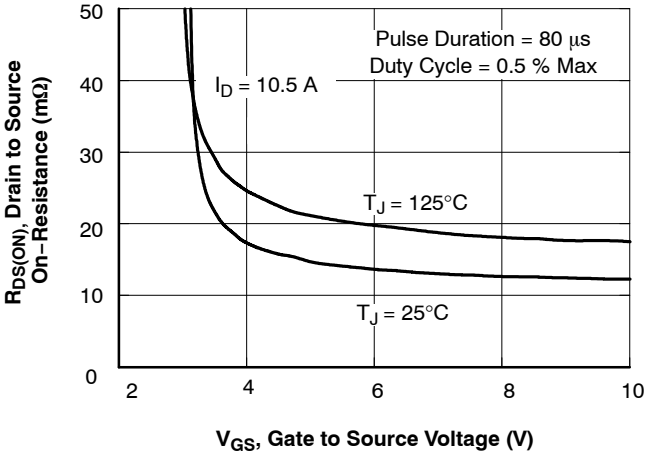


Figure 4. On−Resistance vs. Gate to Source Voltage

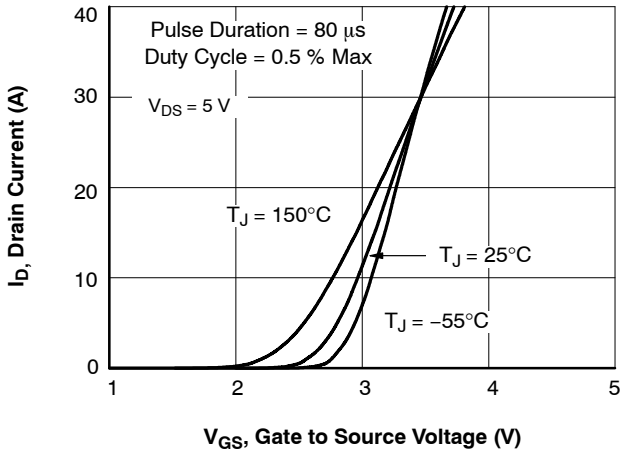


Figure 5. Transfer Characteristics

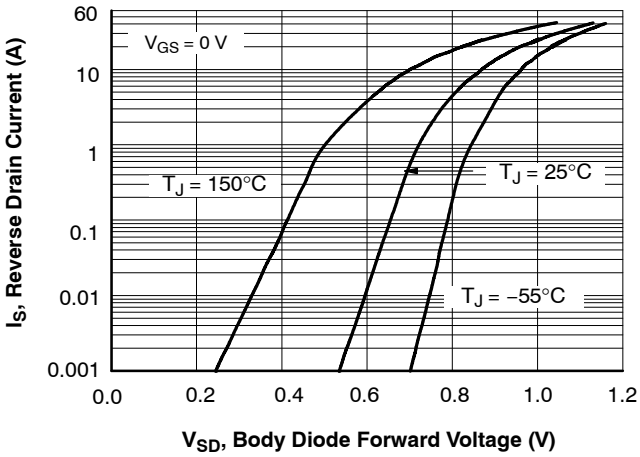


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (continued)

(T_J = 25°C unless otherwise noted)

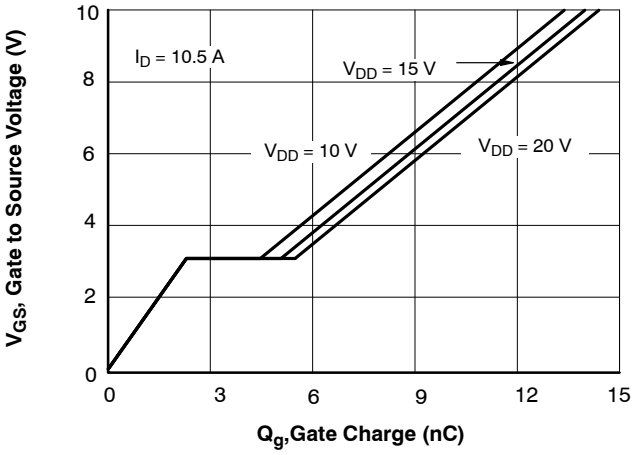


Figure 7. Gate Charge Characteristics

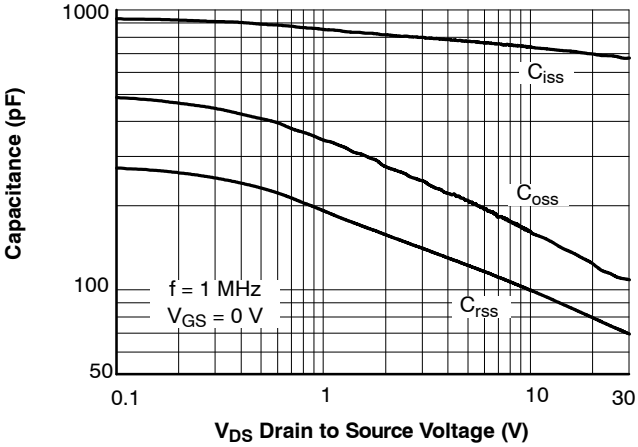


Figure 8. Capacitance vs Drain to Source Voltage

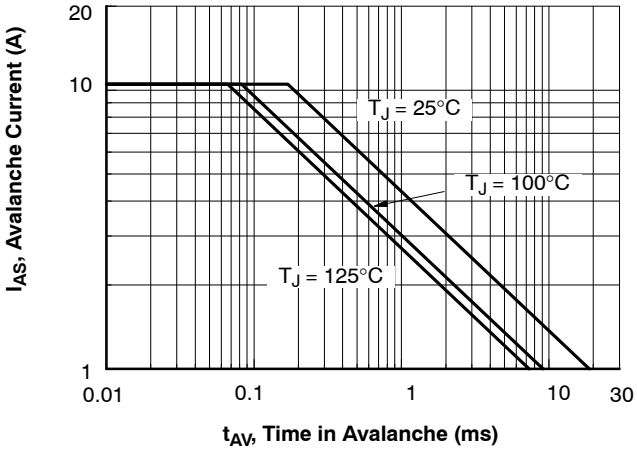


Figure 9. Unclamped Inductive Switching Capability

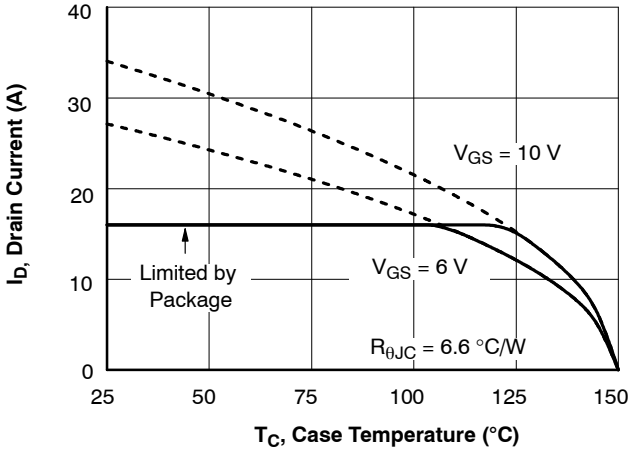


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

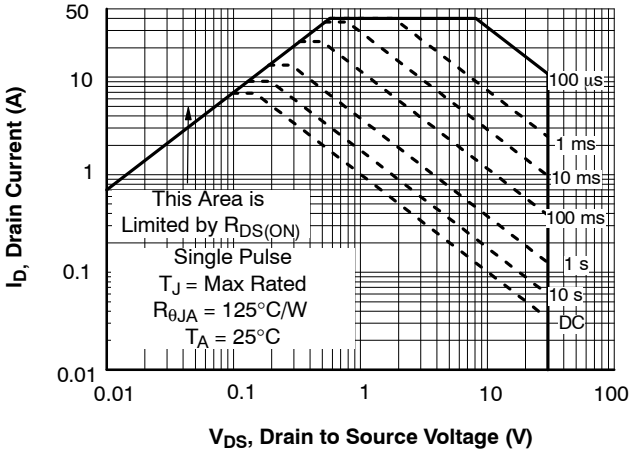


Figure 11. Forward Bias Safe Operating Area

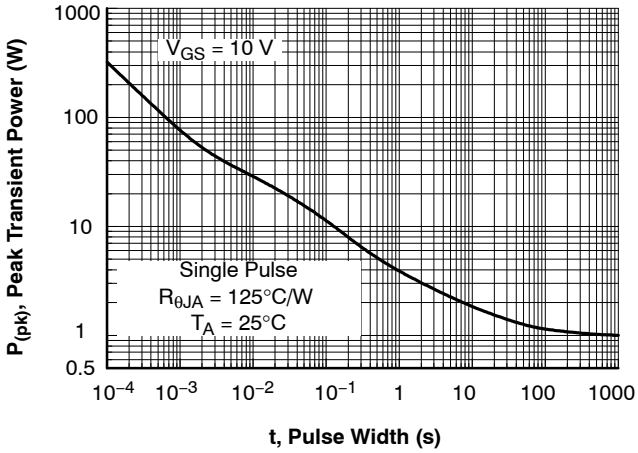


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

(T_J = 25°C unless otherwise noted)

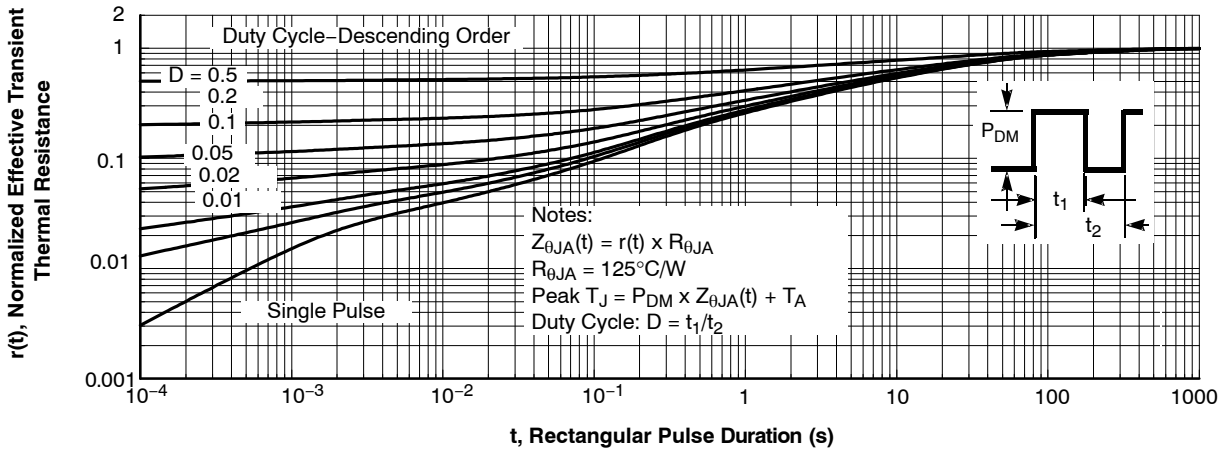


Figure 13. Transient Thermal Response Curve

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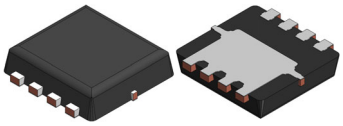
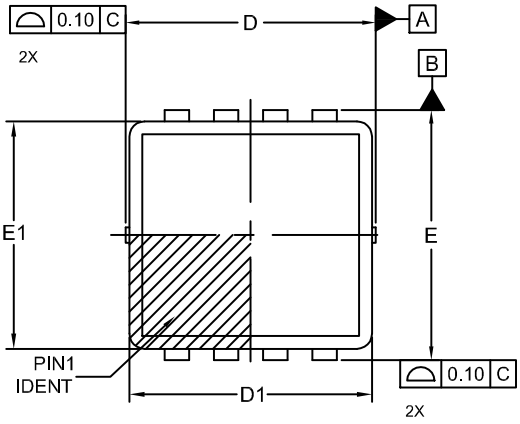
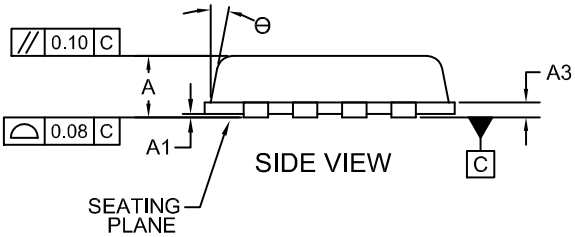


WDFN8 3.3x3.3, 0.65P
CASE 511DR
ISSUE B

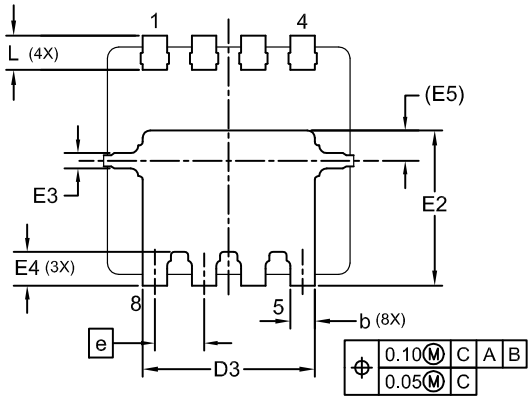
DATE 02 FEB 2022



TOP VIEW



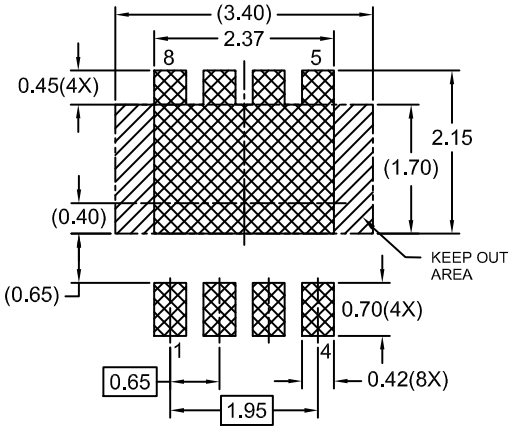
SIDE VIEW



BOTTOM VIEW

NOTES:
A. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
B. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
C. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS. MOLD FLASH PROTRUSION OR GATE BURR DOES NOT EXCEED 0.150MM.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	-	0.05
A3	0.15	0.20	0.25
b	0.27	0.32	0.37
D	3.20	3.30	3.40
D1	3.10	3.20	3.30
D3	2.17	2.27	2.37
E	3.20	3.30	3.40
E1	2.90	3.00	3.10
E2	1.95	2.05	2.15
E3	0.15	0.20	0.25
E4	0.30	0.40	0.50
E5	0.40 REF		
e	0.65 BSC		
L	0.30	0.40	0.50
Θ	0°	-	12°



RECOMMENDED LAND PATTERN

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
▪ = Pb−Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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